imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





AOTF4N90 900V,4A N-Channel MOSFET

General Description			Product Summary					
The AOTF4N90 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications.By providing low R _{DS(on)} , C _{iss} and C _{rss} along with guaranteed avalanche capability this parts can be adopted quickly into new and existing offline power supply designs. For Halogen Free add "L" suffix to part number: AOTF4N90L			V_{DS} $I_{D}~(at~V_{GS}\text{=}10V)$ $R_{DS(ON)}~(at~V_{GS}\text{=}10V)$	1000V@150℃ 4A < 3.6Ω				
			100% UIS Tested 100% R _g Tested					
1	Cop View							
TO-220F TO-220F TO-220F G G G G G G G G G G G G G								
	ŭ	s othorwise n		o s				
Absolute Maximum	ŭ		oted	O S Units				
Absolute Maximum I Parameter	Ratings T _A =25°C unless	Symbol		Units V				
Absolute Maximum	Ratings T _A =25°C unless	Symbol V _{DS}	oted AOTF4N90					
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage	Ratings T _A =25°C unless	Symbol V _{DS} V _{GS}	01ed AOTF4N90 900	V				
Absolute Maximum I Parameter Drain-Source Voltage	Ratings T _A =25°C unless	Symbol V _{DS}	000 <u>407F4N90</u> 900 ±30	V				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V _{DS} V _{GS}	AOTF4N90 900 ±30 4*	V V V				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$	Symbol V _{DS} V _{GS}	AOTF4N90 900 ±30 4* 2.5*	V V V				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ energy C	Symbol V _{DS} V _{GS} I _D I _{DM}	AOTF4N90 900 ±30 4* 2.5* 16	V V V				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ energy C	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR}	AOTF4N90 900 ±30 4* 2.5* 16 2.3	V V A A				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C the energy G dv/dt	Symbol V _{DS} V _{GS} I _D I _{AR} E _{AR}	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5	V V A A MJ MJ V/ns				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C whe energy C dv/dt $T_C=25^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{AR} E _{AR} E _{AS} dv/dt	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37	V V A A MJ MJ MJ V/ns W				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation ^B	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ energy C the energy C the energy C $T_C=25^{\circ}C$ Derate above $25^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dv/dt P _D	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37 0.3	V V A A M A M M M V/ns V/ns W W/ °C				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation ^B Junction and Storage	Ratings $T_A=25^{\circ}C$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C the energy C the energy C the energy C $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range	Symbol V _{DS} V _{GS} I _D I _{AR} E _{AR} E _{AS} dv/dt	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37	V V A A MJ MJ MJ V/ns W				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe	Ratings $T_A=25^{\circ}$ unless $T_C=25^{\circ}C$ $T_C=100^{\circ}C$ c energy C the energy C the energy C $T_C=25^{\circ}C$ Derate above $25^{\circ}C$ Temperature Range rature for soldering	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AR} E _{AR} E _{AS} dv/dt P _D	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37 0.3	V V A A M A M M M V/ns V/ns W V/°C				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation ^B Junction and Storage	Ratings $T_A=25^{\circ}$ unless $T_c=25^{\circ}$ $T_c=100^{\circ}$ energy $^{\circ}$ the energy $^{\circ}$ dv/dt $T_c=25^{\circ}$ Derate above 25^{\circ} Temperature Range rature for soldering se for 5 seconds	$\begin{tabular}{ c c c c } \hline Symbol & V_{DS} & V_{GS} & \\ \hline V_{GS} & & \\ \hline I_D & & \\ I_{DM} & & \\ I_{AR} & & \\ E_{AR} & & \\ E_{AS} & & \\ dv/dt & & \\ \hline P_D & & \\ T_J, T_{STG} & \\ \hline \end{tabular}$	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37 0.3 -55 to 150	V V A A MJ MJ V/ns V/ns W W/ °C C C				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe purpose, 1/8" from ca Thermal Characteris	T_c=25°C T_c=25°C T_c=100°C c energy ^C the energy ^G dv/dt T_c=25°C Derate above 25°C Temperature Range rature for soldering se for 5 seconds stics rameter	$\begin{tabular}{ c c c c } \hline Symbol & V_{DS} & V_{GS} & \\ \hline V_{GS} & & \\ \hline I_D & & \\ I_{DM} & & \\ I_{AR} & & \\ E_{AR} & & \\ E_{AS} & & \\ dv/dt & & \\ \hline P_D & & \\ T_J, T_{STG} & \\ \hline \end{tabular}$	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37 0.3 -55 to 150	V V A A MJ MJ V/ns V/ns W W/ °C C C				
Absolute Maximum I Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current Pulsed Drain Current Avalanche Current ^C Repetitive avalanche Single plused avalance Peak diode recovery of Power Dissipation ^B Junction and Storage Maximum lead tempe purpose, 1/8" from ca Thermal Characteris	T _c =25°C T _c =25°C T _c =100°C C energy ^C che energy ^G dv/dt T _c =25°C Derate above 25°C Temperature Range rature for soldering se for 5 seconds tics rameter -Ambient ^{A,D}	$\begin{tabular}{ c c c c } \hline Symbol & V_{DS} & V_{GS} & \\ \hline V_{GS} & & I_D & \\ \hline I_{DM} & & I_{AR} & \\ \hline I_{AR} & & E_{AS} & \\ \hline dv/dt & & \\ \hline P_D & & \\ \hline T_J, T_{STG} & \\ \hline T_L & & \\ \hline \end{tabular}$	AOTF4N90 900 ±30 4* 2.5* 16 2.3 79 158 5 37 0.3 -55 to 150 300	V V A A mJ W/ns W/°C C C				

* Drain current limited by maximum junction temperature.



Electrical Characteristics (T_J=25^oC unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC	PARAMETERS					
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V, T _J =25℃	900			
		$I_D=250\mu A, V_{GS}=0V, T_J=150^{\circ}C$		1000		V
BV _{DSS} /∆TJ	Zero Gate Voltage Drain Current	ID=250µA, VGS=0V		1		V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V_{DS} =900V, V_{GS} =0V			1	μA
		V _{DS} =720V, T _J =125℃			10	
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V, V_{GS}=\pm 30V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =5V Ι _D =250μΑ	3.4	4.1	4.5	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V_{GS} =10V, I_{D} =2A		2.8	3.6	Ω
g _{FS}	Forward Transconductance	V_{DS} =40V, I_{D} =2A		6		S
V _{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.75	1	V
I _S	Maximum Body-Diode Continuous Current				4	Α
I _{SM}	Maximum Body-Diode Pulsed Current				16	Α
DYNAMI	C PARAMETERS					
C _{iss}	Input Capacitance		580	728	880	pF
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =25V, f=1MHz	41	52	70	pF
C _{rss}	Reverse Transfer Capacitance		4.4	5.5	9	pF
R _g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	2	4	6	Ω
SWITCH	ING PARAMETERS					
Qg	Total Gate Charge	V _{GS} =10V, V _{DS} =720V, I _D =4A	14.5	18.4	22	nC
Q _{gs}	Gate Source Charge		3.5	4.4	5.3	nC
Q _{gd}	Gate Drain Charge		6.4	8	12	nC
t _{D(on)}	Turn-On DelayTime			22		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =450V, I_{D} =4A,		46		ns
t _{D(off)}	Turn-Off DelayTime	$R_{G}=25\Omega$		43		ns
t _f	Turn-Off Fall Time			39		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =4A,dI/dt=100A/μs,V _{DS} =100V	155	196	235	ns
Q _{rr}	Body Diode Reverse Recovery Charge	e I _F =4A,dI/dt=100A/μs,V _{DS} =100V	3.2	4.05	4.9	μC

A. The value of R $_{\rm 6JA}$ is measured with the device in a still air environment with T $_{\rm A}$ =25°C.

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper

dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}=150$ °C, Ratings are based on low frequency and duty cycles to keep initial $T_{J}=25$ °C.

D. The R $_{\rm 0JA}$ is the sum of the thermal impedence from junction to case R $_{\rm 0JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300 μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150°C. The SOA curve provides a single pulse ratin g.

G. L=60mH, I_{AS}=2.3A, V_{DD}=150V, R_G=25\, \odot , Starting T_J=25 ${}^\circ\!\!\!C$

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

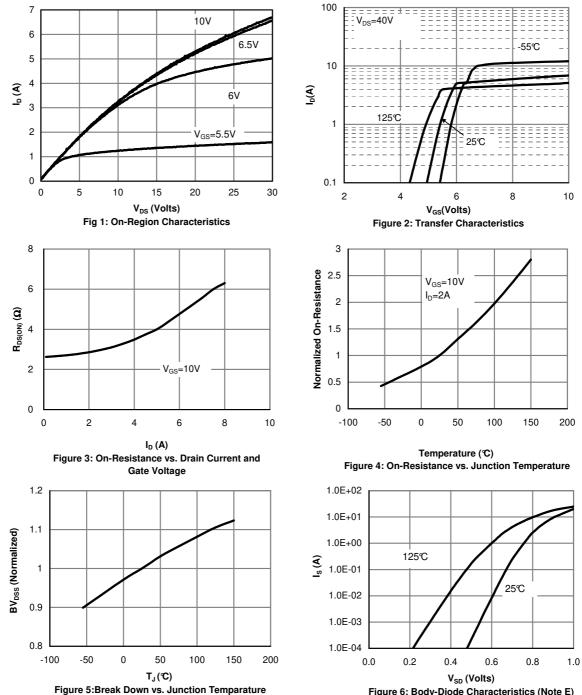


Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

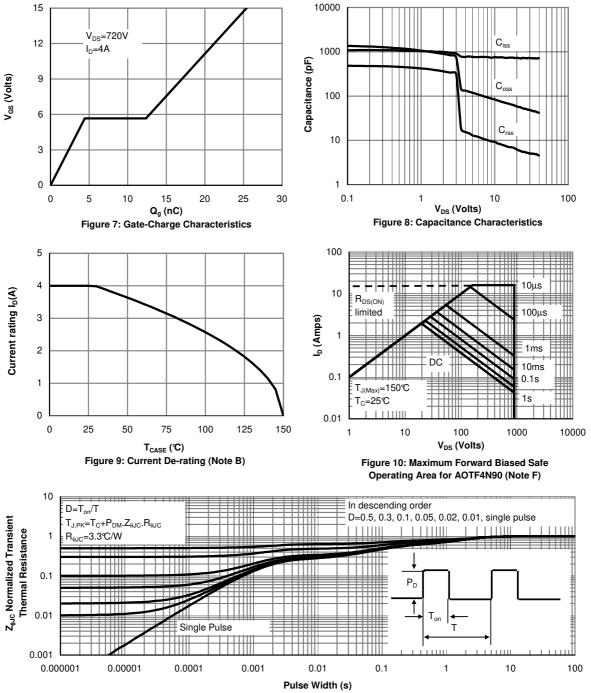
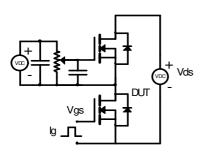
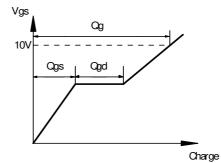


Figure 11: Normalized Maximum Transient Thermal Impedance for AOTF4N90 (Note F)

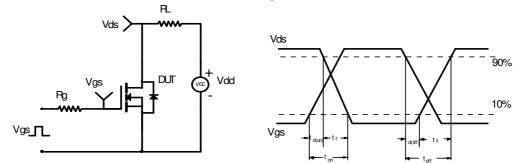


Gate Charge Test Circuit & Waveform

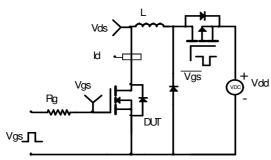


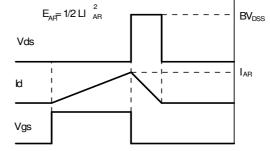


Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

